# Preliminary Reliability Analysis Report Focused on MTBF calculation

August 16, 2017

Prepared by Kwo

Kwon Woong Bee Engineer

Confirm by

Jeong Young Nam Senior Manager

Approved by

An Shin Hu Senior Manager



R&D Quality Assurance Group Quality Assurance Team Security Solution Business

HANWHA TECHWIN Co., LTD

HANWHA PROPRIETARY



### **Description:**

Preliminary reliability prediction (MTBF Calculation) methodologies leveled from devices to system by using Telcordia Issue 1 called SR-332.

- Device: There several methods to predict and electronic device in Telcordia Issue 1 (SR-332) but this document is based on Case-3 of Method-I Part Count when device specification is available. And the other case, this document uses generic reliability data such as EPRD97 or NPRD95
- 2) Assembly: Assembly steady-state failure rate prediction is computed as the sum of the device failure rate prediction for all devices in the assembly and multiplied by the assembly environmental factor.
- 3) System: With the specified reliability parameters, failure criteria, equipment configuration, and operating conditions, the total system failure rate can be calculated as the sum of the assembly failure rates.

## Unit of The Parameters

- 1) Failure rate = ( failure frequencies /  $10^6$  hour )
- 2) MTBF (Mean Time Between Failure): In fact, this system is assumed that all devices and assembly is not repairable. Normal usage of MTBF has a meaning to cover every specific case.

MTBF = 1 / failure rate.

### **Preliminary reliability Prediction Result**

Environment : GF, GU – Ground Fixed, Uncontrolled Temperature : 25  $^{\circ}$ C

## Analog Camera :

MTBF [hours]

MODEL	MTBF	Failure Rate	Product feature	Remark
HCO-6070R	316,245	3.16 x 10⁻ <sup>6</sup>	AHD 2M WDR Analog Bullet IR Camera	